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Optimization of Effective Doping Concentration of Emitter for Ideal c-Si Solar Cell Device with *PC1D* Simulation

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Abstract: Increasing silicon solar cell efficiency plays a vital role in improving the dominant market share of photo-voltaic systems in the renewable energy sector. The performance of the solar cells can be evaluated by making a profound analysis on various effective parameters, such as the sheet resistance, doping concentration, thickness of the solar cell, arbitrary dopant profile, etc., using software simulation tools, such as PC1D. In this paper, we present the observations obtained from the evaluation carried out on the impact of sheet resistance on the solar cell's parameters using PC1D software. After which, the EDNA2 simulation tool was used to analyse the emitter saturation current density for the chosen arbitrary dopant profile. Results indicated that the diffusion profile with low surface concentration and shallow junction depth can improve the blue response at the frontal side of the solar cell. The emitter saturation current density decreases from 66.52 to 36.82 fA/cm² for the subsequent increase in sheet resistance. The blue response also increased from 89.6% to 97.5% with rise in sheet resistance. In addition, the short circuit density and open circuit voltage was also observed to be improved by 0.6 mA/cm^2 and 3 mV for the sheet resistance value of $130 \Omega/\text{sq}$, which resulted in achieving the highest efficiency of 20.6%.

Keywords: crystalline silicon; doping concentration; *EDNA*2; *PC*1*D*; solar cells



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1. Introduction

The energy demand and rate of electricity consumption has significantly increased with urbanization, technological advancements and population growth [1,2], which is primarily addressed by fossil-fuel-based conventional energy resources. The use of conventional energy resources leads to global warming and climate change creating adverse environmental impacts. Therefore, to reduce these impacts, renewable energy resources, such as solar, wind, tidal, biomass, hydro, and geothermal, are considered as an alternative energy generation sources. In addition to the environmental impacts, the renewable energy sources also provide economic and social impacts, thereby, making it a sustainable choice [3].

Solar photovoltaics are considered as a promising type of renewable energy resource due to the abundant availability and cost-effective nature leading to a production of about 200 to 350 $\rm W/m^2$ in hot temperate climatic regions on average. Matthias et al. projected an installation capacity of about 800,000 km² of solar panels to meet the gross estimated

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demand of 16 TW highlighting the drawback of the very low (10%) conversion efficiency of the commercially available solar panels [4].

This alarming nature of the increasing demand and lower efficiency has motivated many researchers across the world to work on optimizing/improving the cell efficiency of the solar panels. Improvement of the efficiency of the solar panels is considered to be more significant than reducing the manufacturing costs when considering the proportional relationship with the rise in the solar cell efficiency and reduction of the cost. Therefore, many simulation and modelling software packages have been developed to simulate the impact of optimizing characteristics, such as the thickness of a solar cell, concentration level of doping elements, type of dopants used, and configuration of the contacts in the solar cell structure.

The crystalline silicon (c-Si) solar cell is the most common type of solar cell used world wide due to the simple structure and effective operating procedure. The c-Si solar cell mainly consists of a moderately doped p-type wafer in the middle with a highly doped n^+ layer on the top and p^+ layer on the rear side. In addition to this, an anti reflecting coating and serial connectors are present in the front side of the solar cell structure as illustrated in Figure 1.

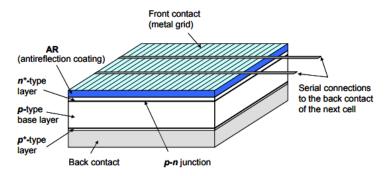


Figure 1. Structure of a c-Si solar cell [5].

From the literature, it is evident that the characteristics of emitter configuration of a c-Si solar cell has a significant influence on the efficiency and many researchers across the world are working towards improving this. State-of-the-art approaches are used to appropriately perform characterization and optimization of the emitter configurations that can lead to a significant efficiency gain; this efficiency gain substantially reduces the cost of the system.

An ideal emitter configuration aims to reduces the (i) recombination losses in the diffused region as well as at the surface of the cell and (ii) resistive losses [6] as the emitter doping profile plays a significant role in controlling the solar cell's device characteristics. In a typical solar cell, the highly doped homogeneous emitter having a low sheet resistance (R_{sheet}) of $40-50~\Omega/\mathrm{sq}$, with a junction depth of 0.4–0.5 µm is used. This heavily doped deeper emitter configurations reduces the contact resistance as highlighted by Stem et al.

However, this heavily doped emitter contributes in the reduction of the blue response as well as the surface passivation [7]. Optimization of I–V characteristics, such as the open circuit voltage (V_{oc}), saturation current density (J_{sc}) and fill factor (FF) play a significant role in increasing the conversion efficiency of the solar cell's without altering its structure by developing an ideal emitter layer as highlighted by Franklin et al. [8].

By introducing a heavy diffusion in the emitter region, the solar cell efficiency can be improved. Therefore, Teinkemper et al. recommends the peak doping concentration should be higher to achieve higher efficiency of the solar cell [9]. However, the heavy doping concentration of the emitter improves the surface passivation, but this creates a drawback by increasing the contact resistivity. Doshi et al. highlighted that the increase in blue response with shallow junction depth, increases the shunting probability, which will influence the decline in the efficiency of the solar cell [10].

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In conventional solar cell processing, emitter formation is a tedious and an expensive process that motivates researchers to conduct simulations before experimentally verifying the performance of the optimized emitter configurations [11]. PC1D is one of the widely used solar cell simulators [12], which will be used for evaluating of the emitter configurations, such as sheet resistance and emitter doping concentration in this paper. PC1D is an open-source, extremely informative, modelling tool that assists in the evaluation of all crucial factors constituting a solar cell.

PC1D allows the variation in parameters, such as bulk doping levels, variation in doping concentration of emitter etc. Moreover, we can visualize the performance of the I–V curve, V_{oc} , J_{sc} , external and internal quantum efficiencies of solar cell in a graphical format [13]. Kim et.al investigated the doping profile effect on the selective emitter solar cells by PC1D [14]. Park et al. studied the influence of the doping profile on the current density, generation rate, recombination rate. and defect density in c-Si solar cells using TCAD simulation [15].

In this present study, we explore the effects of higher sheet resistance of an emitter and analyse the impact on the performance of solar cells. Finally, a detailed analysis of the emitter saturation current density was performed with *EDNA*2 simulation.

2. Solar Cell Modelling Using PC1D

The solar cell electrical and optical behaviour with the change in emitter configurations, such as the sheet resistance and emitter doping concentration was studied using the PC1D software. The advantage of using numerical modelling tools, such as PC1D, in order to optimize the emitter configurations is that the use of these simulation tools reduces the cost, time, and efforts required to analyse the impact of the change in configuration of the solar cells. The PC1D tool considers a basic schematic of the solar cell as illustrated in Figure 2.

PC1D is one of the commonly used numerical modelling simulation tools used for crystalline Si (c-S1) solar cell device simulations. The numerical model incorporated within the PC1D software package represents the quasi-one-dimensional transportation of electrons and holes of a semiconductor material (Solar cells). Equations (1)–(7) illustrate the basic governing equations of the numerical model used in the PC1D software package. A similar models have been created to use the model of a silicon cell, and PC1D is used for optimizing various process parameters, including the ARC coating layer properties [5], etc.

$$J_n = \mu_n \cdot n \cdot \nabla E_{Fn} \tag{1}$$

$$J_p = \mu_p \cdot p \cdot \nabla E_{Fp} \tag{2}$$

 J_n and J_p represent the current densities of the electrons and the holes, respectively. μ_n and μ_p are the mobility of the electron and holes, and n and p are the electron and hole density, respectively. The ∇E_{Fn} and ∇E_{Fp} are the diffusion coefficients, which represent the difference in the electron and hole quasi-Fermi energies E_{Fn} and E_{Fp} . Equations (1) and (2) are the numerical representation of the current densities.

$$\frac{\partial n}{\partial t} = \frac{\nabla \cdot J_n}{q} + G_L - U_n \tag{3}$$

$$\frac{\partial p}{\partial t} = \frac{\nabla \cdot J_p}{q} + G_L - U_p \tag{4}$$

$$\Delta^2 \phi = \frac{q}{\epsilon} \left(n - p + N_{acc}^- - N_{don}^+ \right) \tag{5}$$

Inferences from the law of conservation of charge or the continuity equation lead to the formulation of Equations (3) and (4). where G_L and U_n are generation rate and

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recombination rate, respectively. Equation (5) represents Poisson's equation for solving the electrostatic field problems in which N_{acc}^- and N_{don}^+ are the acceptor and donor doping concentrations.

$$n = N_C F_{1/2} \left(\frac{q\psi + V_n - q\phi_{n,i} + \ln(n_{i,0}/N_C)}{k_B T} \right)$$
 (6)

$$p = N_V F_{1/2} \left(\frac{-q\psi + V_p - q\phi_{p,i} + \ln(n_{i,0}/N_V)}{k_B T} \right)$$
 (7)

In (6) and (7), the effective density of states in the conduction and valence bands are represented as N_c and N_v , respectively, to describe the type of material used, Fermi–Dirac statistics directly related to the band edges. The finite element approach is used to solve the three basic equations that assist in simulating the solar cell behaviours using the PC1D modelling tool. The optimization of the process parameters using the PC1D simulation tool is widely studied in the literature, but the proposed research aims to optimise the design process characteristics of the effective doping concentration of the emitter used in the fabrication of the c-Si solar cells. Finally, the efficiency of c-Si solar cells is calculated using the following Equation (8).

$$\eta = \frac{P_{\text{max}}}{I_{\text{in}}} = \frac{J_{\text{mpp}}V_{\text{mpp}}}{I_{\text{in}}} = \frac{J_{\text{SC}}V_{\text{OC}}FF}{I_{\text{in}}}$$
(8)

where η represents the efficiency of the solar cell, which is calculated using P_{max} , I_{in} , J_{mpp} , V_{mpp} , J_{SC} , V_{OC} and FF that indicates the maximum power, incident power, current at maximum power point, voltage at maximum power point, saturation current density, open circuit voltage, and fill factor, respectively. PC1D is limited to one-dimensional modelling. The doping profiles are approximated by error functions that give the best fit to the experimental data. However, these might not possess the same shape of the doping profiles obtained experimentally. Particularly, the peak surface concentrations for the simulated profiles are overestimated, which might reduce the cell potential.

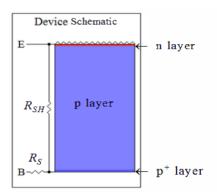


Figure 2. Schematic of the solar cell model [5].

The concentration of the electrons and holes in the silicon layer of the c-Si solar cell is modified and optimized by the process of doping. The doping concentration and the type of doping (shallow or deep) influences the electrical conductivity of the semiconductor material making the solar cell more efficient. The electrical conductivity of the c-Si solar cell depends mainly on the parameters, such as the doping concentration and the mobility of the electrons and holes in the semiconductor region of the solar cell. Figure 3 illustrates the different dopant concentration levels of the c-Si solar cells, and in this paper, we critically test the heavy doping region with varying sheet resistance.

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In this simulation, we considered the uniform distribution across the wafers. A detailed overview of the assumptions considered and the experimental procedure for the simulation is highlighted in the following section.

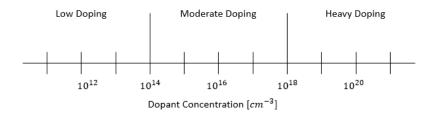


Figure 3. Dopant concentration levels [5].

3. Simulation of c-Si Solar Cell

In this present study, we considered the actual device configuration for optimizing the n^+ pp^+ solar cell by PC1D simulation. Numerous simulations were performed to study the impact of different parameters on the solar cell device performance. The solar cell parameters used for the simulation is depicted in Table 1. The base resistance (0.015 Ω), internal conductor (0.3 S), and light intensity (0.1 W/cm²) were kept constant during simulation, as the doping concentration and the sheet resistance were varied, and the cell performance was evaluated. As recommended by Bremner et al., the AM1.5 G spectrum was used in the modelling of the c-Si solar cell [16].

Table 1. Uniqu	e characteristics	of each appliance u	used in the simulations	[5].
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Characteristics	Value		
Device area	244.32 cm ²		
Front/rear surface texture depth	$54.74^{\circ}/3~\mu m$		
Front/Rear surface coating	$SiN_x - 80 \text{ nm} - \text{n} = 2.03$		
Internal optical reflectance	Enabled		
Thickness	180 μm		
Intrinsic concentration ni @ 300 K	$1 \times 10^{10}~\mathrm{cm}^{-3}$		
n^+ diffusion	$1 \times 10^{20} \ {\rm cm}^{-3}$		
p^+ diffusion	$3 \times 10^{18} \mathrm{~cm^{-3}}$		
Front and rear SRV	10,000 cm/s		
Bulk recombination	100 μs		
Temperature	25 °C		

For detailed analysis of the recombination in an emitter, we used the EDNA2 simulation program [17]. This simulator can determine the following factors: (i) recombination that occurs in both emitter as well as back surface field (BSF) (ii) emitter saturation current density (J_{0e}) and (iii) internal quantum efficiency (IQE) for the chosen dopant profile. In the present study, we applied the following models: Trupke radiative recombination [18], Ritcher Auger recombination [19], Shockley–Read–Hall (SRH) recombination [20] to calculate the effective surface recombination velocity (as 1×10^4 cm/s).

Mobility and band gap were modelled using Klaassen's for mobility[21], Passler's for intrinsic band gap [22], Sentaurus's for density of states model [23], Altermatt's for dopant ionization model [24], Schenk's model for band gap narrowing [25] and Fermi–Dirac statistics [26]. With the above said models and error functions (ERFC), the n^+ (phosphorous) doping profiles with maximum doping concentration of 1×10^{20} cm⁻³ were calibrated. Initially, we analysed the c-Si solar cell's performance with the change in sheet resistance and later with the different doping profile and the results of the these observations are deliberately discussed in the following section.

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4. Results and Discussion

The emitter (n^+) sheet resistance R_{sheet} is one of the imperative parameters that can influence the recombination losses at the front side of the solar cell. Therefore, the improvement in the saturation current density at the emitter, surface, and contact is a concern to be aware of when increasing the sheet resistance of the emitter. In order to study the impact of the emitter sheet resistance R_{sheet} on the efficiency of the solar cell, we fixed the doping concentration as 1×10^{20} cm⁻³ and observed the change in possible junction depth as depicted in Figure 4.

It is clear from the observations that the lower the R_{sheet} , the deeper the junction. To achieve a R_{sheet} of 50 $\Omega/{\rm sq}$, the junction depth should be 0.59 μm . Higher R_{sheet} of 130 $\Omega/{\rm sq}$ was obtained for the shallow junction depth of 0.21 μm . The high R_{sheet} at the emitter are benign for low saturation current density at the front.

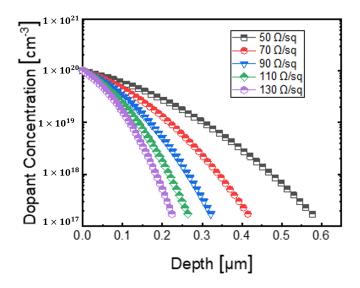


Figure 4. Variation in the R_{sheet} by fixing the emitter dopant concentration 1×10^{20} cm⁻³.

Figure 5 displays the various current and voltage (I–V) parameters, such as (J_{sc} , V_{oc} , FF, and efficiency) of Si solar cell simulated using PC1D against the R_{sheet} . Figure 5 shows an improvement in J_{sc} and slight variation in the V_{oc} with respect to the variation in the R_{sheet} . It is clear that a shallow emitter junction is preferable for highly-efficient solar cells. As the junction depth becomes shallower, the current density increases and, hence, the fill factor. A gain in J_{sc} by 0.6 mA/cm² and V_{oc} by 3 mV was observed for the high R_{sheet} .

This increase in R_{sheet} , lowers the Auger recombination and enhances the quantum efficiency in the short wavelength range. The increase in V_{oc} with increase in R_{sheet} can be attributed to the decrease in front surface doping concentration that contributes to the reduced Auger recombination. It is well known that the V_{oc} is inversely proportional to the reverse saturation current density; thus, the V_{oc} increases with increase in R_{sheet} . Hence, the current photovoltaic industry utilize >90 Ω /sq in its homogeneously diffused n+ emitters and is expected to increase >130 Ω /sq by 2030 [27], which is evident from the results observed in the simulation.

Though the lightly doped emitter with R_{sheet} of 130 Ω/sq yielded a high V_{oc} , in actual cell fabrication process there would be a drop in V_{oc} after front grid metallization. Screen-printed Ag pastes with lower surface doping concentration can significantly reduce this V_{oc} loss. However, with lightly doped emitters, the metal recombination losses increase due to the etching nature of the Ag pastes. This limits the cell efficiency gain in experimentally fabricated cells [28]. To overcome this limitation, a dual print approach i.e., printing bus bars with less aggressive pastes and then printing fine metal fingers might reduce the metallization-induced recombination losses and in turn increase the conversion efficiency of the Si solar cells.

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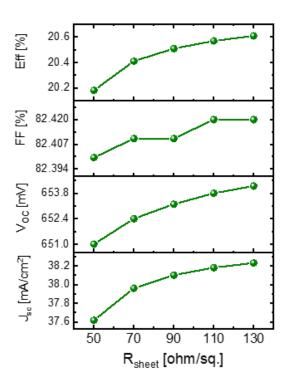


Figure 5. I–V characteristics as a function of R_{sheet} .

The doping concentration was fixed, and the change in junction depth was observed. Quantum Efficiency (QE) is one of the most crucial parameter of a solar cell. It is the ratio of number of carriers collected by the solar cell to the number of incident photons for a given wavelength [29]. The increase in quantum efficiency indicates the improvement in carrier collection. Thus, QE reveals the contribution of photons with different wavelengths towards J_{SC} .

IQE is another parameter utilized to characterize the quality of solar cells in the short wavelength range of 300–500 nm. Most of the light in the blue wavelength region is absorbed by the emitter. The increase in J_{sc} for the shallow junction depth (130 Ω/sq) is attributed towards enhancement in IQE. Figure 6 depicts the simulated internal quantum efficiency with respect to the variation in R_{sheet} . The spectral response also determines/indicates the recombination rate on the frontal surface of c-Si solar cell, which is closely related to the junction depth.

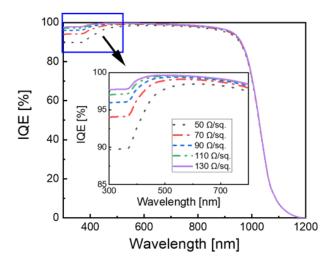


Figure 6. Simulated internal quantum efficiency as a function of R_{sheet} .

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The decrease in total J_{0e} contributes to the increase in R_{sheet} . Table 2 shows the split of the recombination mechanism predominant in each R_{sheet} . It is well known that three different kind of recombination occurs in semiconductor. The radiative recombination is almost negligible for all the R_{sheet} as the emitted photon has energy, such as at the band gap, and is therefore weakly absorbed.

The Auger recombination decreases with higher R_{sheet} . Auger recombination is vital at high carrier concentrations, which is caused by either heavy doping or high level injection at concentrated sunlight. Auger recombination limits the lifetime and cell efficiency. The SRH recombination increases slightly with an increase in R_{sheet} .

$R_{sheet} \ [\Omega/ ext{sq.}]$	IQE_{E} [%]	J _{0e,radiative} [fA/cm ²]	J _{0e,Auger} [fA/cm ²]	J _{0e,SRH} [fA/cm ²]	J _{0e,total} [fA/cm ²]
50	89.6	0.03	52.53	13.96	66.52
70	93.7	0.02	38.97	14.6	53.59
90	95.8	0.02	30.65	14.92	45.59
110	96.9	0.01	25.35	15.09	40.45
130	97.5	0.01	21.62	15.19	36.82

Table 2. Impact of variation in the emitter saturation current densities as a function of R_{sheet} .

By fixing the R_{sheet} , the emitter dopant concentration was varied as depicted in Figure 7. The heavy doping concentration (1 \times 10¹⁸ cm⁻³) and shallow doping concentration (1 \times 10²¹ cm⁻³) ended in deeper and shallow junction, respectively. Though lightly doped emitter with high surface concentration is expected to have a good emitter properties (low J_{0e} , better blue response), the junction depth is too shallow. This shallow junction induced high shunt resistance and series resistance, thereby, leading to poor solar cell performance. Similarly, the heavily doped emitter ended in a deeper junction, which decreased the series resistance, and thus a better FF was due to a low surface dopant concentration; however, J_{sc} and V_{oc} dropped due to poor surface passivation with high dopant concentration. Thus, a doping concentration in the order of 1 \times 10²⁰ cm⁻³ with good junction depth is preferred.

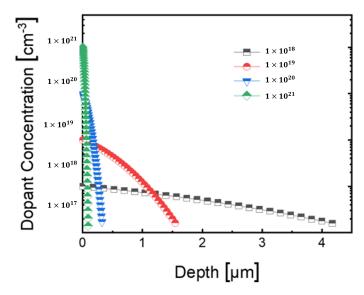


Figure 7. Variation in the emitter dopant concentration by fixing R_{sheet} .

5. Conclusions

The effect of the emitter sheet resistance on the performance of a silicon solar cell was studied. The phosphorus dopant profiles with a peak dopant concentration of 1×10^{20} cm⁻³ were fixed, and the sheet resistance was varied using *EDNA2* simulation. The R_{sheet} was

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varied from 50 to 130 Ω /sq. The results show that the emitter saturation current density decreased from 66.52 to 36.82 fA/cm² with an increase in the sheet resistance during n^+ (phosphorus) diffusion.

This decrease in the values of J_{0e} is attributed to the decrease in Auger recombination. The internal quantum efficiency increased from 89.6% to 97.5% for the corresponding surge in sheet resistance. The short circuit density and open circuit voltage increased by 0.6 mA/cm² and 3 mV, respectively, for the 130 Ω /sq sheet resistance, which showed the highest efficiency of 20.6%. However, metallization-induced recombination losses occurred on the phosphorus-diffused emitters with varying surface doping concentrations and junction depths. Thus, in the future, we aim to study the metallization-induced recombination on the various doping profiles, which will be helpful for our fellow researchers in the PV industry for improving device performance.

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